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Determination of spin torque efficiencies in heterostructures with perpendicular magnetic anisotropy

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We report that by measuring a current-induced hysteresis loop shift versus in-plane bias magnetic field, the spin-Hall effect (SHE) contribution of the current-induced effective field per current density χ_{SHE} can be estimated for Pt- and Ta-based magnetic heterostructures with perpendicular magnetic anisotropy. We apply this technique to a Pt-based sample with its ferromagnetic (FM) layer being wedged deposited and discover an extra effective field contribution χ_{Wedged} due to the asymmetric nature of the deposited FM layer. We confirm the correlation between χ_{Wedged} and the asymmetric depinning process in FM layer during magnetization switching by magneto-optical Kerr microscopy. These results indicate the possibility of engineering deterministic spin-orbit torque switching by controlling the symmetry of domain expansion through the materials growth process.

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Current-induced spin-orbit torque (SOT) has been shown to be an efficient way of manipulating the magnetization in heavy-metal/ferromagnet (HM/FM) heterostructures. Unlike conventional spin transfer torque [1,2] in which the source of spin angular momentum comes from a ferromagnetic polarizer layer, SOTs arise from either the bulklike spin-Hall effect (SHE) [3,4] of the nonmagnetic (NM) HM layer or Rashbatype spin-orbit interaction [5,6] at the interface. SOTs can be utilized to achieve efficient magnetization switching [7–10], ultrafast domain-wall (DW) motion [6,11,12], and microwave generation through magnetic oscillations [13,14] in spintronic device applications.

SOTs are typically studied in magnetic heterostructures with perpendicular magnetic anisotropy (PMA), and in general both a Slonczewski-like and a field-like torque can be present. The Slonczewski-like torque is most relevant to magnetization switching: It manifests as an effective field $H_{\rm eff}$ with an out-of-plane (easy-axis) component that can reverse the magnetization or drive DWs if a component of the magnetization lies along the current-flow direction. The most common measurement schemes used to quantify the Slonczewski-like SOT efficiency $\chi \equiv H_{\rm eff}/J_e$ (effective field per unit current density J_e) include ferromagnetic resonance techniques [15–17], low-frequency harmonic voltage measurements using small ac currents [18–20], and analysis of current-induced DW motion in thin magnetic strips [11,12,21,22]. Current-induced SOT switching of PMA films under an in-plane bias field is another convenient means for determining the sign of χ ; however, a quantitative estimate of its magnitude is usually difficult to obtain in such measurements due to the complicated magnetization reversal process [23,24].

In this paper we examine the role of domain nucleation and DW propagation in SOT-assisted magnetization switching in HM/FM bilayer systems with PMA. We show that the currentinduced shift of the out-of-plane hysteresis loop as a function of in-plane bias field can be well explained by a simple currentassisted DW propagation model. This simple measurement an estimate of the chiral Dzyaloshinskii-Moriya effective field $|H_{\text{DMI}}|$, which is a measure of the strength of Dzyaloshinskii-Moriya interaction (DMI) [25,26], that stabilizes Néel-type DWs in these structurally inversion asymmetric structures. Finally, we show that in wedged films with a small thickness gradient there exists a large apparent contribution χ_{Wedged} to the Slonczewski-like SOT efficiency that derives from structural asymmetries in the domain nucleation/propagation process, which is further examined by magneto-optical Kerr (MOKE) microscopy. Importantly, we find that this effect can provide a means for deterministic SOT switching of a PMA film in the absence of an in-plane bias field. This result may offer an alternate explanation to similar recently reported observations interpreted in terms of an out-of-plane effective field generated by in-plane symmetry breaking [27].

scheme allows χ to be quantified and simultaneously provides

In magnetic heterostructures with PMA, the SHE-induced Slonczewski-like SOT can drive Néel DWs similarly to an out-of-plane applied field in a direction that depends on the DW chirality. Homochiral Néel DWs can be stabilized by the DMI in ultrathin films lacking inversion symmetry [11,12,21,28], and it has been shown that current-induced magnetization switching and DW motion in HM/FM bilayers can be explained by a SHE+DMI scenario [11,23]. As schematically shown in Fig. 1(a), the charge current J_e flowing along the x axis in the NM layer of a magnetic heterostructure will generate a transverse spin current J_s along the z axis via the SHE and inject spins into FM layer with their spin-polarization direction $\hat{\sigma}$ parallel to the y axis. This spin current, when acting upon a Néel-type DW with the typical Walker profile, will give rise to an effective field $H_{\text{eff}}^z = \chi J_e$ [29] through the spin transfer torque mechanism, where $\chi = \chi_{SHE} \cos \Phi =$ $(\pi/2)(\hbar\xi_{\rm DL}/2e\mu_0M_st_{\rm FM})\cos\Phi$. Here $\xi_{\rm DL}$, M_s , $t_{\rm FM}$, and Φ represent the effective spin-Hall-induced (dampinglike) torque efficiency [30,31], the saturation magnetization of the FM, the thickness of FM, and the angle between the DW moment and the x axis, respectively. In the case of homochiral Néel DWs, this H_{eff}^{z} can lead to DW motion but not domain expansion in the absence of an external magnetic field due to the opposite signs of H_{eff}^z for up-down (cos $\Phi = 1$) and down-up (cos $\Phi = -1$) DWs. However, upon the application

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FIG. 1. (a) Schematic of current-induced domain wall motion in a magnetic heterostructure with PMA in the absence of external magnetic field. H_{eff}^z represents the SHE-induced effective field acting upon the Néel-type chiral domain wall. v_{DW} represents the domain-wall motion direction. (b) Schematic of current-induced domain-wall motion (domain expansion) with an in-plane external magnetic field H_x to realign domain-wall moments.

of an in-plane bias field H_x that is strong enough to overcome the effective DMI field H_{DMI} , the DW moment in the Néel-type walls will realign parallel to H_x as shown in Fig. 1(b). In this case H_{eff}^z will be pointing along the same direction for both up-down and down-up walls and therefore facilitates domain expansion or contraction, depending on the polarities of J_e and H_x . It is then straightforward to conceive that not only for *current*-driven DW motion and/or magnetization switching, but also for an out-of-plane *field*-driven switching process, the applied current J_e and in-plane bias field H_x should play significant roles.

To study the interplay between J_e , H_x , and resulting H_{eff}^z during field-driven switching, we prepared four sets of PMA Hall-bar samples: (A) $\|Ta(2)/Pt(4)/Co(1)/MgO(2)/Ta(1), (B)$ $\|Ta(2)/Pt(4)/CoFeB(1)/MgO(2)/Ta(1), (C)\|Ta(6)/CoFeB(1)$ /MgO(2)/Ta(1), and (D) $||Ta(2)/Pt(4)/Co(t_{Co})/MgO(2)/Ta(1)$ with 0.6 nm $\leq t_{Co} \leq 1.6$ nm being wedged deposited. || stands for the thermally oxidized Si substrate, and the numbers in parentheses represent nominal thickness of sputtered films in nanometers. All films were sputter deposited in an AJA ATCseries sputtering chamber with a base pressure of $\leq 10^{-7}$ Torr and a working Ar pressure of 4 mTorr. The substrate-to-target separation was ≈ 15 cm with an oblique angle, and the uniform thickness of films was achieved by substrate rotation during deposition. The wedged deposition of the Co layer for series (D) was achieved by sputtering with the rotation function off. Hall bars with lateral dimensions of $5 \times 12 \,\mu \text{m}^2$ were patterned using standard photolithography, and Ti(5)/Pt(50) pads were deposited by sputtering for electrical contact.

As schematically shown in Fig. 2(a), we measured the AH voltage V_H versus out-of-plane field H_z to characterize magnetization switching in the Hall-bar devices as a function of applied dc current I_{dc} and in-plane bias field $H_{in plane}$ (either along the x axis or the y axis). Representative normalized AH loops for Pt(4)/Co(1)/MgO(2) sample (A) with $H_x = 2500$ Oe and $I_{dc} = \pm 6$ mA are shown in Fig. 2(b). Slight vertical offsets are introduced for both AH loops for clarity. The opposite loop shifts along the H_z axis of the hysteresis loops corresponding to opposite polarities of I_{dc} indicate the existence of a current-induced H_{eff}^z due to a Slonczewski-like torque. By plotting the switching fields H_{SW} for both down-to-up and up-to-down transitions (defined as the zero-crossing

fields of the normalized V_H) as functions of I_{dc} , we obtained a switching phase diagram as shown in Fig. 2(c). Two effects should be considered to explain the variation of switching boundaries: linear tilting contribution from current-induced $H_{eff}^z(I_{dc})$ and the reduction of coercivity from Joule heating ($\propto I_{dc}^2$), which means that the switching fields can be written as $H_{SW}^{DN-to-UP} = H_{eff}^z(I_{dc}) + H_c(I_{dc}^2)$ and $H_{SW}^{UP-to-DN} =$ $H_{eff}^z(I_{dc}) - H_c(I_{dc}^2)$. Therefore, the joule heating contribution can be eliminated by considering only on the horizontal shift of the hysteresis loop center H_0 , defined as the mean of the two switching fields $H_0 \equiv (H_{SW}^{DN-to-UP} + H_{SW}^{UP-to-DN})/2 = H_{eff}^z$. The linear variation of H_0 with respect to I_{dc} then provides a good estimate of H_{eff}^z/I_{dc} . For comparison, we also plot the results measured from sample (A) in the absence of H_x in Fig. 2(d). As expected, no contribution other than joule heating was observed since the Néel-type DWs were not realigned in order to affect the domain expansion/contraction processes.

To verify this measured $H_{\rm eff}^z/I_{\rm dc}$ is indeed coming from the SHE, we performed the same measurements on samples (B) and (C), namely, PMA Pt(4)/CoFeB(1)/MgO(2) and Ta(6)/CoFeB(1)/MgO(2). The only difference between these two samples is the choice of NM underlayer that is the source of the SHE. In Fig. 3(a) we plot the representative AH loops for Pt/CoFeB/MgO and a similar shift to I_{dc} as in Pt/Co/MgO was found. The I_{dc} dependence of the measured H_{eff}^z for Pt/CoFeB/MgO is summarized in Fig. 3(b). It can be seen that by reversing the polarity of H_x , the slope of H_{eff}^z/I_{dc} also reverses. This is consistent with the prediction from a SHE + DMI scenario. In Figs. 3(c) and 3(d) we show results from the Ta/CoFeB/MgO sample. An opposite trend of H_{eff}^z/I_{dc} was found compared to the Pt case. Since Pt and Ta are known to have opposite spin-Hall angles [8], this opposite trend of $H_{\rm eff}^{z}/I_{\rm dc}$ between the two cases is again consistent with the SHE picture and cannot be explained by a current-induced joule heating origin.

In Figs. 4(a)-4(c), we summarize the measured $\chi = H_{\text{eff}}^z/J_e$ as a function of applied in-plane field either along the x axis or the y axis for sample (A) Pt/Co/MgO, sample (B) Pt/CoFeB/MgO, and sample (C) Ta/CoFeB/MgO, respectively. The current density in the NM layer was calculated from I_{dc} , dimensions of the Hall-bar device, and resistivities of the NM/FM layers. For Pt/Co/MgO [Fig. 4(a)], χ increases



FIG. 2. (a) Schematic of anomalous Hall (AH) voltage measurements. (b) AH loops for a Pt(4)/Co(1)/MgO(2) sample with dc currents $I_{dc} = \pm 6$ mA and an in-plane bias field $H_x = 2500$ Oe. (c) Switching (depinning) fields H_{SW} for down-to-up (red triangles) and up-to-down (blue circles) magnetization reversals as functions of I_{dc} , with $H_x = 2500$ Oe. $H_0 = H_{eff}^z$ (black squares) represent the center of the AH loops. The solid line represents linear fit to H_0 data. (d) H_{SW} and H_0 as functions of I_{dc} in the absence of in-plane bias field ($H_x = 0$ Oe).



FIG. 3. (a) AH loops for a Pt(4)/CoFeB(1)/MgO(2) sample with dc currents $I_{dc} = \pm 4$ mA and an in-plane bias field $H_x = 1000$ Oe. H_{eff}^z represents the shift of the AH loops due to the SHE. (b) H_{eff}^z for Pt(4)/CoFeB(1)/MgO(2) as a function of I_{dc} under different bias fields. (c) AH loops for a Ta(6)/CoFeB(1)/MgO(2) sample with dc currents $I_{dc} = \pm 2$ mA and an in-plane bias field $H_x = 100$ Oe. (d) H_{eff}^z for Ta(6)/CoFeB(1)/MgO(2) as a function of I_{dc} under different bias fields. Solid lines are linear fits to the data.



FIG. 4. The measured effective χ as a function of applied in-plane field for (a) Pt(4)/Co(1)/MgO(2), (b) Pt(4)/CoFeB(1)/MgO(2), and (c) Ta(6)/CoFeB(1)/MgO(2) samples. Blue squares and red circles represent data obtained with the external in-plane magnetic field applied along the *x* axis (H_x) and the *y* axis (H_y), respectively. (d) The estimated effective DMI field H_{DMI} as a function of anisotropy field H_{an} for the presented samples. The dashed line represents the criterion above which skyrmions and other spin textures can be realized.

quasilinearly with H_x and saturates at $H_x \approx 5000$ Oe, whereas no significant trend or variation of χ was observed with the application of H_{y} . This observation is consistent with a domainexpansion picture: The DW orientations in the heterostructure change from an average of $\langle \cos \, \Phi \rangle \approx 0$ to $\langle \cos \, \Phi \rangle \approx 1$ when H_x approaches H_{DMI} , whereas H_y simply reorients the DWs into a Bloch-type configuration ($\Phi = \pm \pi/2$). Based on this model, we estimated $\chi_{SHE} \approx 75 \, \text{Oe}/10^{11} \text{A}/\text{m}^2$ and $|H_{\rm DMI}| \approx 5000 \,\text{Oe}$ for Pt/Co/MgO from the saturation value of χ and the saturation field, respectively, in Fig. 4(a). For the Pt/CoFeB/MgO sample, we found $\chi_{SHE} \approx 72Oe/10^{11} A/m^2$ and $|H_{\rm DMI}| \approx 2500$ [Fig. 4(b)]. The close correspondence of χ_{SHE} between the Pt/CoFeB/MgO and the Pt/Co/MgO cases is expected since the spin-Hall metal is the same. However, the significant difference in the DMI effective field for CoFeB- and Co-based structures suggests that the exchange interaction is particularly sensitive to the FM layer composition. Finally, for the Ta/CoFeB/MgO sample, in Fig. 4(c), we estimated $\chi_{SHE} \approx$ $-500e/10^{11}A/m^2$ and $|H_{DMI}| \approx 2500e$. Note that the estimated $|H_{\rm DMI}| \approx 2500$ for Pt/CoFeB/MgO and $|H_{\rm DMI}| \approx$ 250Oe for Ta/CoFeB/MgO are comparable to the previously reported values of $|H_{\rm DMI}| \approx 2800 \,\text{Oe}$ for Pt/CoFe/MgO and $|H_{\rm DMI}| \approx 80$ Oe for Ta/CoFe/MgO structures [22].

In Fig. 4(d) we plot $|H_{\text{DMI}}|$ for these samples against their measured perpendicular anisotropy fields $H_{\text{an}} = 2K_{\text{u,eff}}/M_s$, where $K_{\text{u,eff}}$ is the effective perpendicular magnetic anisotropy energy density [32]. We find that for the Ta/CoFeB/MgO sample, the DMI is just beyond the threshold required to stabilize Néel DWs, given by $|H_{\text{DMI}}|/H_{\text{an}} = 2/\pi$ [29]. This indicates

the possibility of stabilizing two-dimensional spin textures, such as skyrmions in Ta-based magnetic heterostructure as well as its variations [33,34].

The effective dampinglike torque efficiencies (effective spin-Hall angles) corresponding to the measured χ_{SHE} are $\xi_{DL} \approx 0.15$ and $\xi_{DL} \approx -0.12$ for Pt and Ta samples, respectively. These numbers are in good agreement with other recently reported values that were obtained through harmonic voltage measurements [20,30] and spin torque switching measurements [8,31]. Moreover, the magnitude of the DMI exchange constant |D| can be calculated from the measured $|H_{\rm DMI}|$ by using $|D| = \mu_0 M_s \Delta |H_{\rm DMI}|$ [29], where Δ is the DW width and relates to exchange stiffness constant A and effective PMA energy density $K_{u,eff}$ through $\Delta = \sqrt{A/K_{u,eff}}$. Using M_s and $K_{u,eff}$ obtained by vibrating sample magnetometry and by assuming $A \approx 1.5 \times 10^{-11} \text{ J/m}$ [35], we estimated $|D| \approx 3.0 \text{ mJ/m}^2$ for Pt/Co/MgO, $|D| \approx 1.8 \text{ mJ/m}^2$ for Pt/CoFeB/MgO, and $|D| \approx 0.6 \text{ mJ/m}^2$ for Ta/CoFeB/MgO samples, respectively. Again, these numbers are reasonable and close to the range of previously reported values in similar magnetic heterostructure systems [22,28,36].

Recently it has also been shown that by engineering the gradient of H_{an} in deposited films [27] or by artificially tilting the anisotropy axis away from the film normal [37], deterministic SOT switching in the absence of external magnetic field can be realized for Ta/CoFeB/oxide heterostructures. A similar effect is also observed in structures with the NM layer being TaN, Hf, or W and is attributed to the details during asymmetric materials growth [38]. However, this additional

contribution to the SOT has not yet been reported for Pt-based magnetic heterostructures. Here we show that, by performing the same measurements as previous sections on sample (D) Pt/Co(wedge)/MgO, an additional contribution to χ is observed and found to originate from the nature of the wedged structure χ_{Wedged} . We further show that this contribution can be quantified and distinguished from χ_{SHE} using the measurement scheme described above.

As shown in Fig. 5(a), unlike samples (A)–(C), sample (D) before patterning has a wedged-deposited Co layer 0.6 nm \leq $t_{\rm Co} \leq 1.6$ nm. After patterning, the wedged profile is along the y axis of the device [Fig. 1(a)] with only a slight variation of Co thickness ($\leq 10^{-3}$ nm) for each Hall-bar device. Note that unlike in Ref. [27], here the wedged-deposited layer is the FM rather than the capping layer. As shown in Fig. 5(b), the measured χ has nonzero offsets at $H_{\chi} = 0$ Oe for both $\langle t_{\rm Co} \rangle = 0.65$ - and $\langle t_{\rm Co} \rangle = 1.09$ -nm samples. Here $\langle \rangle$ represents the averaged nominal thickness of the measured device. This extra SOT contribution in the absence of an in-plane applied field is significantly different from the uniformly deposited case. We denote this offset as the contribution from the wedged structure χ_{Wedged} . More importantly, the sign of χ_{Wedged} can change depending on $\langle t_{Co} \rangle$, which is similar to the dependence of H_{eff}^z on $\langle t_{\text{TaO}_x} \rangle$ reported in Ref. [27]. By increasing the applied field to $H_x \ge |H_{\rm DMI}|$, the measured χ again saturates with $\chi \approx \chi_{SHE} + \chi_{Wedged}$. The resulting trend allows us to unambiguously determine χ_{SHE} , χ_{Wedged} , as well as $|H_{DMI}|$ for these wedged-deposited samples through this simple protocol.

We summarize the measured χ_{SHE} and χ_{Wedged} of sample (D) as a function of $\langle t_{\rm Co} \rangle$ in Fig. 5(c). $\chi_{\rm SHE}$ reaches its maximum at $\langle t_{\rm Co} \rangle = 1.09 \, \rm nm$ and is close to that of the uniformly deposited case [sample (A)], whereas the magnitude of χ_{Wedged} reaches its extreme values at $\langle t_{Co} \rangle = 0.65 \text{ nm}$ with $\chi_{Wedged} \approx 10 \text{Oe}/10^{11} \text{A/m}^2$ and $\langle t_{Co} \rangle = 1.22 \text{ nm}$ with $\chi_{Wedged} \approx -14 \text{Oe}/10^{11} \text{A/m}^2$. This indicates that the two SOT contributions have different FM layer thickness-dependent trends and it is therefore possible that they can be tuned or optimized through interface and structural engineering in different ways. We also note that the maximum magnitude of $|\chi_{Wedged}| \approx 14 Oe/10^{11} A/m^2$ for the wedged-deposited Pt/Co/MgO samples presented here is comparable to the reported values for Ta/CoFeB/MgO and Ta/CoFeB/TaO_x systems [27,39]. However, current-induced switching in the absence of external field cannot be demonstrated with $|I_{dc}| \leq$ 8 mA (corresponding to $H_{\rm eff}^z \leq 40$ Oe) due to the large coercivity ($H_c \ge 100 \,\text{Oe}$) of the present films. Further materials engineering to reduce Hc in Pt/Co/MgO heterostructures while maintaining high $|\chi_{Wedged}|$ should allow for realizing deterministic current-induced switching without any external field in this Pt-based heterostructure.

In Table I, we summarize $|H_{DMI}|$ and the estimated DMI exchange constant |D| alongside with H_c , H_{an} , and $K_{u,eff}$ of the wedged-deposited samples with different $\langle t_{Co} \rangle$. It can be seen that both $|H_{DMI}|$ and |D| peak at $\langle t_{Co} \rangle = 1.09$ nm, with $|H_{DMI}|_{max} \approx 4500$ Oe and $|D|_{max} \approx 2.91 \text{mJ/m}^2$. The monotonic decrease of $|H_{DMI}|$ and |D| with respect to Co thickness for $\langle t_{Co} \rangle \ge 1.09$ nm is similar to the trend reported by Belmeguenai *et al.* in their ultrathin Pt/Co/AlO_x films [40], which might indicate an interfacial origin of the observed effect. However, in our case, the trend reverses as $\langle t_{Co} \rangle \le 1$ nm.

TABLE I. Summary of the magnetic properties and estimated effective DMI fields H_{DMI} in wedged-deposited Pt/Co(wedge)/MgO samples with various Co thicknesses $\langle t_{\text{Co}} \rangle$. H_c , H_{an} , and $K_{\text{u,eff}}$ represent the coercive field, anisotropy field, and effective perpendicular magnetic anisotropy energy density of wedged-deposited samples, respectively.

$\langle t_{\rm Co} \rangle$ (nm)	H _c (Oe)	H _{an} (Oe)	$K_{\rm u,eff}$ (Merg/cm ³)	$ H_{\rm DMI} $ (Oe)	$ D (\mathrm{mJ/m^2})$
0.65	75	1900	1.05	1100	1.45
0.80	105	3340	1.84	2000	1.99
0.92	278	6150	3.38	2900	2.12
1.00	295	7540	4.15	4000	2.64
1.10	264	7900	4.34	4500	2.91
1.23	255	5120	2.82	3100	2.49
1.43	242	3200	1.76	1600	1.62
1.52	170	1750	0.96	1000	1.37

This might be related to the change in Pt/Co interfacial condition [41] as evidenced by the decrease in H_{an} and $K_{u,eff}$ while decreasing Co thickness in this regime.

To gain insight on the microscopic origin of the structuralinduced χ_{Wedged} , we study the magnetization switching process in both the uniformly deposited sample (A) and the wedgeddeposited sample (D) through wide-field MOKE microscopy. As shown in Fig. 5(d), we found that by applying an outof-plane field H_z , the preferred nucleation sites are very different for devices from sample (A) (uniform Co) and from sample (D) (wedged Co). For devices with a uniform Co layer, the domains randomly nucleate at all edges and then further expand to accomplish magnetization reversal. For devices with a wedged Co layer (in this case a sample with $\langle t_{\rm Co} \rangle = 1$ nm), however, the nucleation processes for both up-to-down and down-to-up transitions always begin at the lower edge (thicker Co side) then the DW propagates across the device to the other edge (thinner Co side) (see Supplemental Material [42] for animated image files). Within the Co thickness range where unambiguous out-of-plane MOKE contrast can be obtained, $0.92 \text{ nm} \leq \langle t_{Co} \rangle \leq 1.2 \text{ nm}$, the nucleation process behaves similarly. It is surprising that this asymmetric nucleation/depinning process can be so significant even for a device with FM thickness variation $\leq 10^{-3}$ nm. Since the variation in Co thickness across the wedge is extremely small, we speculate that this effect might be related to the profile of local depinning field across the sample as evidenced by the global variation of coercive field H_c along the wedgeddeposition axis (see Table I). This preferred nucleation on one edge of the device is drastically different from other reports [27,38,39] in which no observable asymmetric field-driven nucleation process is found. We believe that, although the existence of $dH_{\rm an}/dy$ gradient-induced fieldlike SOT [27] cannot be completely ruled out, a major contribution of the measured χ_{Wedged} originates from the asymmetric nature of nucleation/depinning process in these wedged-deposited Pt/Co/MgO devices. If this is the case, then further studies on the interplay among structural factors, especially the DMI [43] and the current-induced (Oersted) field [44–46] at the edges in these magnetic heterostructures, will be beneficial for engineering SOT switching without external bias field.



FIG. 5. (a) Schematic of the wedged-deposited film. After patterning, the current was applied along the into-the-plane direction during measurements in this cross-sectional view. (b) The measured χ as a function of H_x for wedged-deposited Pt(4)/Co(0.65)/MgO(2) and Pt(4)/Co(1.09)/MgO(2) heterostructures. The contributions from the SHE and the wedged structure are indicated as χ_{SHE} and χ_{Wedged} , respectively. (c) Co thickness $\langle t_{Co} \rangle$ dependence of χ_{SHE} and χ_{Wedged} . (d) Representative MOKE images for Pt(4)/Co(1)/MgO(2) devices during magnetization switching. The upper (lower) figures represent the switching mode for a uniformly (wedged)-deposited sample.

To summarize, we demonstrate that by characterizing the shift of out-of-plane hysteresis loops under different dc currents and in-plane bias fields, the SOT efficiency $\chi = H_{\text{eff}}^z/J_e \approx \chi_{\text{SHE}}$ for Pt/Co/MgO, Pt/CoFeB/MgO, and Ta/CoFeB/MgO heterostructures can be obtained. The effective DMI field H_{DMI} in the above heterostructures can also be estimated simultaneously by this straightforward protocol. We can also estimate the extra contribution of χ due to bilateral symmetry breaking of the wedged-deposited FM layer in Pt/Co(wedge)/MgO, χ_{Wedged} with the same method. This together with the Kerr microscopic observation of the asymmetric domain nucleation in Pt-based wedged heterostructures provide insightful information on the roles of preferred nucleation sites and nucleation mode in engineering towards SOT switching in the absence of external fields.

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